

# Search Notes



Application/Control No.

10/669,085

Examiner

Yon Couso

Applicant(s)/Patent under Reexamination

EIAN ET AL.

Art Unit

2624

## SEARCHED

Class	Subclass	Date	Examiner
382	285		
	286		
	293		
	294		
	295		
	308		
	276		
	154	1-4-07 gm	
	100		
	118		
348	49		
	50		
	46		
	135		
345	419		
	420		
	424		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG Pat	searched		
Interference	search		
included	1-4-07 gm		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East searched		
IEEE author		
searched	1-4-07 gm	
PRM inventor		
searched		